

Application/Control No.	Applicant(s)/Pate Reexamination	ent under
10/510,617	DENG, WENLO	NG
Examiner	Art Unit	
Patricia Leith	1655	

CEARCHED						
SEARCHEU						
Subclass	Date	Examiner				
		SEARCHED Subclass Date				

		INTERFERENCE SEARCHED					
Subclass	Date	Examiner					
	Subclass	Subclass Date					

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST:JPO,EPO,DERWENT,USPATF ULL,USPGPUBS,OCRBACKFILE updated	4/26/2009	PL		
Inventor name search updated	4/26/2009	PL		